Recent progress in atomic layer deposition of molybdenum disulfide: a mini review

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ABSTRACT As a kind of specially modified chemical vapor deposition (CVD), atomic layer deposition (ALD) has long been used to fabricate thin films. The self-limiting reaction of ALD endows the films with excellent uniformity and precise controllability. The thickness of the films obtained by ALD can be controlled in an atomic scale (0.1 nm) on a large-area substrate even with complex structures. Therefore, it has recently been employed to produce the two-dimensional (2D) materials like MoS₂. In this mini-review, the research progress in ALD MoS₂ is firstly summarized. Then the influences of precursors, substrates, temperature, and post-annealing treatment on the quality of ALD-MoS₂ are presented. Moreover, the applications of the obtained MoS₂ as an electrochemical catalysator are also described. Besides the perspective on the research of ALD of MoS₂, the remaining challenges and promising potentials are also pointed out.

Keywords: MoS₂, chemical vapor deposition (CVD), atomic layer deposition (ALD), two-dimensional (2D) materials

INTRODUCTION

Recently, as one of the dimensional (2-D) materials, MoS₂ has attracted wide attention owing to its excellent semiconducting and optical properties [1–5]. For layered MoS₂, the structure of hexagonal networks connected by covalent bonds of Mo and S atoms is very stable, and the weak interlayer-binding relies on the van der Waals force [6,7], which endows MoS₂ with the band-gap structure depending on the layer number strongly. When the bulk MoS₂ is exfoliated into monolayer, its band-gap will increase from ~1.2 eV (indirect) to ~1.8 eV (direct) [8,9]. Meanwhile, the current on/off ratio (1×10^8) and the carrier mobility ($15 \text{ cm}^2 \text{ V}^{-1} \text{ s}^{-1}$) at room temperature give MoS₂ huge possibilities in electronics and optoelectronics [6,10,11].

Continuous efforts are made for achieving monolayer

or ultrathin MoS₂ films. Although mechanical exfoliation from bulk MoS₂ crystals is a common method to obtain monolayer MoS₂, the efficiency is too low to feed the demands of large-scale fabrications [12,13]. The chemical vapor deposition (CVD) has been a useful way to producing thin MoS₂ films by sulfurizing MoO₃ films between 850 and 950°C [14] or Mo films at 750°C [15], 900°C [16] and 1,050°C [17], directly depositing on Au [18], modified SiO₂ [19] or bare SiO₂ [20–22] between 530 and 800°C using Mo- and S-precursors, which indicates that the precursors, substrates and temperature influence the qualities of the obtained films. A flat substrate ensures the growth of a high quality MoS₂ film with a smooth surface and small lattice mismatch rather than nanostructures with large aspect ratios. However, the CVD method is unsuitable for mass fabrication owing to the poor reproducibility and reliability. As a kind of specially modified CVD, atomic layer deposition (ALD) is also used to grow thin films by the self-limiting chemical reaction. The chemical reaction in time sequence can be broken by dividing a complete reaction into two half-reactions in one ALD cycle. One half-reaction cannot stop until the active sites at the surface are depleted, then beginning the other half-reaction [23–27]. During the ALD, the chemical reaction on a new atomic layer is directly related to the previous layer, which makes every reaction only deposit one atomic layer. Due to the self-limiting reaction, not only the thickness of the films can be controlled at an atomic scale, but also the uniformity can be kept on a large-area substrate even with complex structures [28]. Moreover, ALD has a high reproducibility because the growth is insensitive to excessive precursors. Therefore, ALD has been an excellent method to fabricate 2-D MoS₂ films.

According to Fig. 1, where recent research progress in the preparation of MoS₂ by CVD [14–19,21–22] and ALD

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Figure 1 Research progress in the preparation of MoS₂ by CVD and ALD.

[29–38] is shown, CVD contains two different means. One is the thermal vapor sulfurization where the MoS₂ film is obtained by sulfurizing the pre-deposited molybdenum film at high temperature. The other is thermal vapor deposition where Mo- and S-precursors enter the reactor at the same time to deposit the MoS₂ film. Like CVD, ALD also contains two different means. One is the optimization of process parameters while MoCl₅ and H₂S are used as the precursors. The other is to find the novel precursors. Although ALD of MoS₂ appears later, it will be able to grow monolayer MoS₂ as same as the CVD.

Our group has been able to obtain monolayer MoS₂ directly by ALD, and the thickness of MoS₂ can be locally controlled layer by layer [36,39,40]. In this review, both the research progress in ALD of MoS₂ and the application prospect of the obtained MoS₂ as an electrochemical catalysator are shown. According to the discussion about the influences of the precursor, substrate, temperature, and post-annealing treatment on the quality of ALD-MoS₂, the challenges and potentials to obtain high-quality MoS₂ by ALD are also pointed out.

ALD OF MoS₂ FILMS

Tan *et al.* [29] firstly prepared MoS₂ by ALD on a sapphire substrate while MoCl₅ and H₂S were used as Mo- and S-precursors at 300°C. As shown in Fig. 2, one ALD cycle contains four steps: pulse and purge MoCl₅, pulse and purge H₂S. In the growth process, the corresponding chemical adsorption and reaction can be [39] (A) Mo-SH*+MoCl₅→Mo-S-MoCl₄*+HCl; (B) MoCl₄*+H₂S→Mo-SH*+HCl+S, where * denotes the surface species.

Figure 2 Schematic showing of the ALD of MoS₂.

MoCl₅ can be adsorbed to the substrate (A) or reacted with H₂S (B) by the self-limiting reaction. The MoS₂ films with a controllable thickness and uniform coverage can be fabricated by controlling the AB sequence. At the beginning, MoCl₅ is adsorbed to the bare substrate by the hydroxyl group, $|\text{-OH}^* + \text{MoCl}_5 \rightarrow |\text{-O-MoCl}_4^* + \text{HCl}$, where |− denotes the surface.

Therefore, the chemical functional group like hydroxyl on the substrate surface should be noticed in the initial growth, especially for mono- or few-layer MoS₂. In addition, there are two questions also need to be paid attention. On the one hand, the by-product contains HCl and S, which can corrode and damage the ALD reactor. On the other hand, because ALD is carried out at relatively low temperature, the as-grown MoS₂ always presents a low crystallinity and the post-annealing is usually necessary to achieve a high crystal quality. Accordingly, the precursor, substrate, temperature and post-annealing treatment have important influences on the quality of the MoS₂ film obtained by ALD. Therefore, these factors will be focused on in the next part.

Precursors and qualities of MoS₂ films obtained by ALD

Mo- and S-precursors may strongly affect the quality of MoS₂ obtained by ALD. However, it is a big challenge that finding or synthesizing suitable precursors for ALD of MoS₂. Furthermore, it is difficult to obtain a Mo-precursor that can rapidly react with H₂S, which is a frequently-used S-precursor in ALD of MoS₂. The reactivity and the volatility of the precursors ensure the self-limiting surface reaction. This depends on not only the fundamental chemical science but also the industrial engineering. The progress of the ALD technology is determined by the development of high quality precursors. Since MoCl₅ and H₂S as precursors opened the

Figure 3 (a) AFM image for the MoS₂ film grown on sapphire at 300°C using MoCl₅ and H₂S. Reprinted with permission from Ref. [29], Copyright 2014, Royal Society of Chemistry. (b) TEM images for the MoS₂ film grown on Au at 250°C using MoCl₅ and H₂S. Reprinted with permission from Ref. [41], Copyright 2017, American Chemical Society. (c) Raman spectra comparing MoS₂ films obtained by ALD at 375 and 475°C. Reprinted with permission from Ref. [33], Copyright 2016, American Vacuum Society. (d) AFM image for the MoS₂ film grown on SiO₂ at 450°C using MoCl₅ and H₂S. Reprinted with permission from Ref. [36], Copyright 2017, IOP Publishing Ltd.

prelude of ALD of MoS₂ in 2014 [29], how to produce the high quality MoS₂ film by ALD has become a hot spot. On the one hand, the two precursors, MoCl₅ and H₂S are still used, and the film quality is improved by optimizing the process parameters [33,36,39–41]. On the other hand, the new precursors are tested [30,31,37,38,42–47].

For the first time, MoCl₅ and H₂S were used to grow the MoS₂ film on a sapphire substrate at 300°C. The atomic force microscopy (AFM) image of the as-grown MoS₂ film [29] is shown in Fig. 3a, where the grain with an obscure shape indicates the MoS₂ film is amorphous and the thickness per ALD cycle (GPC) is 0.21 nm/cycle. When the substrate is Au (Fig. 3b), the as-grown MoS₂ film is still amorphous [41] due to the low growth temperature. Subsequently, while the temperature rose to 475°C [33], the uniform MoS₂ film grown on a quartz substrate with the diameter of 150 mm can be obtained. According to Raman spectra (Fig. 3c), the crystallinity of the MoS₂ film grown at 475°C was obviously improved compared with that obtained at 375°C. Moreover, by the continuous optimization of process parameters, the MoS₂ film with triangle grains (Fig. 3d) was directly obtained at

450°C on a SiO₂ substrate without the post-annealing [36]. However, the grain size of ~100 nm is much smaller than that obtained by CVD. Continuous efforts have been made to find the new precursors with which the high quality MoS₂ film is directly obtained by ALD.

Mo(NMe₂)₄ with a high activity was used to react with H₂S for ALD of MoS₂ on the amorphous Al₂O₃ substrate at 150°C [38]. Owing to the high reactivity of Mo(NMe₂)₄, the reaction can be carried out at a very low temperature (80°C). The grown MoS₂ films can be directly patterned by the photolithography for the micro-nano devices on a large scale. However, the crystallinity of the obtained MoS₂ film is very poor due to the low temperature. CH₃S₂CH₃ was also used to react with Mo(NMe₂)₄ [45]. The obtained MoS₂ film with a poor crystallinity is also owing to the low growth temperature. While Mo(CO)₆ and CH₃S₂CH₃ were chosen as Mo- and S-precursors, the MoS₂ film can directly grow on a SiO₂/Si substrate at 100°C [30]. Thicknesses of the films against the exposure time of Mo(CO)₆ and CH₃S₂CH₃ were used to confirm the self-limiting reactions of the precursors. The grown MoS₂ film still has a low crystallinity owing to the low growth temperature. H₂S was also used to react with Mo(CO)₆ on a wafer-scale SiO₂/Si substrate at 165°C [35]. The grown MoS₂ film with a precise controllability and favorable uniformity is also amorphous. Moreover, the H₂S plasma with a higher reactivity was used to react with Mo(CO)₆ on SiO₂ at 175°C [37]. The MoS₂ film could also grow on a wafer-scale SiO₂ while Mo(thd)₃ and H₂S were used as precursors at 300°C [46]. Although, this is the highest growth temperature when the organometallic compounds are used as Mo-precursors, the films just have nano-crystalline structures.

Some precursors for ALD of MoS₂ that have been reported in literatures are listed in Table 1. The grain size and GPC of the grown MoS₂ film are variable with the precursor, substrate, and growth temperature. While MoCl₅ and H₂S are used as Mo- and S-precursors, the grain size increases from ~6.1 to ~120 nm as the growth temperature rises from 250 to 450°C, which indicates the higher temperature is propitious to ALD of MoS₂. Meanwhile, as novel Mo-precursors, metal-organic compounds such as Mo(CO)₆, Mo(thd)₃ and Mo(NMe₂)₄ exhibit higher reactivities than MoCl₅ at low temperature. The grown films have the favorable conformity and uniformity, but their crystallinity and GPC are low. As described above, metal-organic and metal-halide compounds are used as Mo-precursors for ALD of MoS₂, where the metal-organic presents a higher reactivity, lower crystallinity and GPC. Moreover,

Table 1 Various Mo- and S- precursors for ALD of MoS₂

Mo-precursor	S-precursor	Temp. (°C)	Substrate	GPC (nm/cycle)	Grain size	Ref.
MoCl ₅	H ₂ S	300	Sapphire	0.21	Amorphous	[29]
MoCl ₅	H ₂ S	250	Au	/	6.1 nm	[41]
MoCl ₅	H ₂ S	375	SiO ₂	0.025	Amorphous	[33]
MoCl ₅	H ₂ S	430–470	Si, SiO ₂	0.38	35–120 nm	[39,40]
MoCl ₅	H ₂ S	450	SiO ₂	0.65	100 nm	[36]
Mo(CO) ₆	CH ₃ S ₂ CH ₃	100–120	SiO ₂	0.11	Amorphous	[30]
Mo(CO) ₆	H ₂ S	155–175	Co, SiO ₂	0.074	Amorphous	[43,35]
Mo(CO) ₆	H ₂ S plasma	175–200	SiO ₂	0.05	20 nm	[37]
Mo(NMe ₂) ₄	H ₂ S	60–120	Al ₂ O ₃	/	Amorphous	[38]
Mo(CO) ₆	H ₂ S plasma	200	Si	/	5–20 nm	[42]
Mo(thd) ₃	H ₂ S	300	Si, etc.	0.025	10–30 nm	[46]
Mo(NMe ₂) ₄	CH ₃ S ₂ CH ₃	50	SiO ₂	/	Amorphous	[45]
MoF ₆	H ₂ S	200	Si	0.06	Amorphous	[47]

although the grain size can be increased by elevating the growth temperature, it is still much smaller than that obtained by CVD. Therefore, the precursors that can be directly and safely used to fabricate the MoS₂ film with high quality are still in need.

ALD temperature windows of MoS₂

ALD is carried out within a temperature range, the ALD window related to the precursors [48]. As shown in Fig. 4a, the ALD window of MoCl₅ and H₂S is kept in 440–470°C [39]. If the temperature is lower than 440°C, the surface reactions will be incomplete. The chemical reactivity and occupation of MoCl₅ and H₂S can be improved by elevating the temperature. However, if the temperature is higher than 470°C, the re-evaporation of the grown MoS₂ film leads to the decrease of GPC. While Mo(CO)₆ is used to replace MoCl₅ as Mo-precursor [35], the ALD window shown in Fig. 4b is in the range of 155–175°C. The surface reactions will also be incomplete at the temperature lower than the floor of the window. However, above the window, unlike MoCl₅, the disordered stacks from the thermal decomposition of Mo(CO)₆ bring an increase of GPC. While the other metal-organic Mo(NMe₂)₄ and Mo(thd)₃ are used as Mo-precursors, ALD windows are 60–120 and 275–325°C, respectively [38,46].

Compared with CVD, the lower temperature of ALD leads to the MoS₂ film with a lower crystallinity. Moreover, while the metal-halide is used as the Mo-precursor, the higher ALD window brings the higher crystallinity of MoS₂. As described above, the ALD window depends on the activity of the precursor, and

Figure 4 ALD temperature windows using different precursors. (a) MoCl₅ and H₂S. Reprinted with permission from Ref. [39], Copyright 2017, Elsevier. (b) Mo(CO)₆ and H₂S. Reprinted with permission from Ref. [35], Copyright 2014, Royal Society of Chemistry.

the MoS₂ film with a high crystallinity needs to grow at a high temperature in the window.

ALD substrates of MoS₂

As mentioned above, an ALD cycle contains two individual self-limiting surface reactions. Within the ALD window, it is necessary that a full coverage of monolayer can be realized by the precursor pulse, and the surface reactions will stop by themselves owing to the exhaustion of surface active sites, which endows ALD with a stable GPC and makes it insensitive to any further increase of the pulse length. By this stable GPC coming from the self-limiting reactions, the uniform and ultrathin MoS₂ films can grow on the substrates even with complex structures, such as wires, powders, tubes, and holes/pores [25–27], which are the uniqueness of ALD. According to the crystallinity and orientation of the MoS₂ films, not only the precursors but also the

Figure 5 (a) A top view of MoS₂. Reprinted with permission from Ref. [49], Copyright 2013, American Vacuum Society. (b) TEM image of MoS₂ by ALD on silica nano-bead. (c) d_{001} spacing. Reprinted with permission from Ref. [45], Copyright 2017, Royal Society of Chemistry. (d) Hydroxyl groups on the surface of the substrate. (e) Water contact angles of Si and Al₂O₃ substrates. Reprinted with permission from Ref. [39], Copyright 2017, Elsevier. (f) Raman spectra for ALD MoS₂ films on etched and unetched substrate. Reprinted with permission from Ref. [33], Copyright 2016, American Vacuum Society.

substrates play an important role in ALD of MoS₂.

On a sapphire substrate, the triangular grain with the size of $\sim 2\ \mu\text{m}$ can be obtained (by post-annealing) [29]. This may be attributed to the hexagonal crystal structure of the sapphire. The atomically smooth ($\text{RMS} < 0.1\ \text{nm}$) C-planes matches the (0001) planes of 2-H MoS₂ (Fig. 5a). This is propitious to the nucleation and growth of the large-size monocrystal MoS₂ [49,50]. When the MoS₂ film is coated on a silica nano-bead surface [45], the (0001) planes of MoS₂ perpendicular to the substrate can be observed (Fig. 5b, c). This structure can increase the number of active edge sites of the MoS₂ films. In addition, the species and density of hydroxyl groups on the substrates are also very important to ALD of MoS₂, especially for mono- or few-layer MoS₂. In the initial stage of ALD, the MoS₂ films are chemically adsorbed on the substrates through the hydroxyl groups. There are two different hydroxyl groups on the surface of substrates (Fig. 5d), hydrogen-bonded hydroxyl and isolated hydroxyl [51–53]. Above 200°C, dehydroxylation will remove the hydrogen-bonded hydroxyl groups firstly. However, the isolated hydroxyl groups keep stable under 400°C [52]. Therefore, to obtain high quality MoS₂ films, the interference of hydrogen-bonded hydroxyl should be excluded. A preheating process of the substrate at about 200°C before the growth is necessary. The acid washing and the oxygen plasma treatment can increase the density

of hydroxyl groups on the surface of substrates. Moreover, the density can also be increased by covering the hydroxyl-rich seed layer on the substrates. The amorphous Al₂O₃ with abundant hydroxyl groups (Fig. 5e) is more suitable for ALD of MoS₂ than the Si substrate [39]. The microcosmic surface structure of the substrates will also affect the crystallinity of the MoS₂ films. According to the Raman spectra (Fig. 5f), the obtained MoS₂ films on the etched SiO₂ substrates have a higher crystallinity than those on the unetched substrates [33]. To obtain the high-quality MoS₂ films, the crystal structure, surface functional groups and microcosmic structure of the substrate need to be considered.

POST-ANNEALING OF MoS₂ OBTAINED BY ALD

Due to the low ALD window of MoS₂, the as-deposited MoS₂ films are commonly amorphous and/or nanocrystalline. To obtain the high crystallinity MoS₂ film, post-annealing at the elevated temperature is usually necessary. In the post-annealing process, parameters such as the temperature, temperature-ramping speed, duration, and environment (Ar₂ and/or S₂ atmosphere) should be considered. For the conventional semiconductor thin films [54,55], some changes usually in the heat treatments such as defects annihilation, stress build-up and release, morphological changes, and dopant activation may also

Figure 6 (a) Raman spectra of the as-deposited and sulfur-annealed MoS₂ films. (b) Corresponding photoluminescence spectra. XPS spectra of Mo (c) and S (d). Reprinted with permission from Ref. [33], Copyright 2016, American Vacuum Society.

appear in the crystallization induced by post-annealing to the as-grown MoS₂ films. Although the nano-crystalline MoS₂ films can directly grow by ALD at 475 °C using MoCl₅ and H₂S as precursors, the crystallinity of the films can be improved by post-annealing in sulfur atmosphere [33]. Raman spectra of MoS₂ films before and after annealing are shown in Fig. 6a, where the full width half maximum (FWHM) of E_{2g}¹ and A_{1g} peaks is used to indicate the crystallinity. After post-annealing in sulfur atmosphere above 700 °C, the two peaks become strong and narrow, which indicates the high crystallinity of the as-grown MoS₂ films. This can also be confirmed by the change of photoluminescence (PL) peaks before and after annealing (Fig. 6b). The X-ray photoelectron spectroscopy (XPS) of the as-grown and sulfur annealed MoS₂ films are shown in Fig. 6c, d. The stoichiometric ratios of the films before and after post-annealing are determined by the intensity ratios of S 2p_{3/2} and Mo 3d_{5/2} peaks. The increase of the S/Mo ratio from 1.4 to 2.0 after annealing above 600 °C suggests the improved substoichiometric sulfur ratio by high-temperature annealing in sulfur atmosphere.

The amorphous MoS₂ (Fig. 7a) can be transformed into triangular MoS₂ grains (Fig. 7b) with a size of ~2 μm on the sapphire after annealing at 800 °C in sulfur ambient [29]. This is the largest monocrystalline MoS₂ grown by

Figure 7 AFM images for as-grown (a) and annealed (b) MoS₂ films on sapphire substrates. Reprinted with permission from Ref. [29], Copyright 2014, Royal Society of Chemistry. (c) Cross-sectional TEM images of the MoS₂ film annealed at 900 °C. Reprinted with permission from Ref. [30], Copyright 2014, Royal Society of Chemistry. Cross-sectional TEM images of as-grown (d) and sulfurized (e) MoS₂ on p-Si wafers at 700 °C. Reprinted with permission from Ref. [42], Copyright 2017, Royal Society of Chemistry.

Table 2 Post-annealing processes of as-grown MoS₂ films

As-grown				Post-annealing				
Mo-precursor	S-precursor	S/Mo	Grain size	Temp. (°C)	S/Mo	Grain size	Atmosphere	Ref.
MoCl ₅	H ₂ S	1.97	Amorphous	800	2.03	20 μm	S	[29]
Mo(CO) ₆	CH ₃ S ₂ CH ₃	1.21	Amorphous	900	2.01	Nano-crystalline	Ar	[30]
MoCl ₅	H ₂ S	1.4	Amorphous	860–920	2	Nano-crystalline	H ₂ S, S	[33]
Mo(CO) ₆	H ₂ S	1.5	Amorphous	900	2	Nano-crystalline	H ₂ S, Ar	[35]
Mo(NMe ₂) ₄	H ₂ S	/	Amorphous	1,000	/	200 nm	S	[38]
Mo(CO) ₆	H ₂ S plasma	1	6–10 nm	600	2	14 nm	H ₂ S	[42]

ALD so far, which reveals the great potential of ALD in producing crystalline MoS₂. Amorphous MoS₂ has been obtained on the amorphous Al₂O₃ [38]. After annealing for 5 h at 1,000°C in sulfur ambient, the crystalline MoS₂ film consisting of crystallites (~20 nm) can be observed. The as-grown amorphous MoS₂ also can be parallel to the SiO₂ substrate (Fig. 7c) after annealing for 5 min at 900°C in Ar ambient [30]. Cross-sectional TEM images of MoS₂ grown at 200°C and annealed at 700°C on p-Si wafers [42] are shown in Fig. 7d, e. The grain sizes of the as-grown MoS₂ are in the range of about 6–10 nm and the (002) plane spacing is about 6.1 Å. When the post-annealing is carried out at 700°C in sulfur ambient, MoS₂ grains grow to about 14 nm and the (002) plane of MoS₂ will be in parallel to the Si substrate. These indicate the crystallinity is improved after post-annealing. The MoS₂ obtained by post-annealing is the 2H phase. Thermodynamically, the 2H phase is more stable than 1T and 1T' phases. They can be transformed into the 2H phase under heating. Post-annealing of the MoS₂ films are shown in Table 2. The temperature above 600°C and the atmosphere such as S, H₂S, and Ar are generally used for annealing the as-grown MoS₂. The crystallinity and substoichiometric sulfur of the as-grown MoS₂ films can be improved by the high-temperature annealing. Because the ALD temperature of MoS₂ is relatively low, post-annealing is required to obtain the MoS₂ films with a high crystallinity. Not only the crystallinity but also the substoichiometric sulfur of the MoS₂ films can be improved by post-annealing.

APPLICATIONS OF MoS₂ OBTAINED BY ALD

Pt is considered to be the most efficient catalyst for the electrochemical hydrogen evolution reaction (HER). However, Pt is insufficient and expensive. In fact, the HER activity is generally determined by the Gibbs free energy of hydrogen adsorption (ΔG_{H^*}) [56,57]. Although

MoS₂ as a HER catalyst has become a hot spot of research due to the small ΔG_{H^*} on its edge sites [58], how to conveniently and economically increase the edge sites is still a problem for improving the HER activity [59–62]. Recently, amorphous or nanocrystal MoS₂ obtained by ALD exhibits a high HER activity because they can enlarge the area of exposed edge sites [31,34,41,42].

HER polarization curves of a bare Au and two MoS₂ films with different thickness obtained by ALD are shown in Fig. 8a. When the current density reaches 100 μA cm⁻², the overpotential is designated as the onset potential. The onset potentials (165 and 181 mV) of thick and thin MoS₂ films are much smaller than that of bare Au (222 mV), which indicates the MoS₂ films have a better activity than the bare Au and the activity can be improved by increasing the thickness. HER polarization curves of the bare carbon fiber paper (CFP) and MoS₂ films obtained by different ALD cycles are shown in Fig. 8b. For the MoS₂/Au catalyst, the overpotential of 254 mV is needed at the current density of 5 mA cm⁻². However, at the same overpotential, the double current density can be obtained in the MoS₂/CFP catalyst, which may be owing to the large active surface area. Tafel slope *b* and exchange current density *j*₀ obtained from Fig. 8a and b are listed in Table 3. Although the *j*₀ of bare Au is about 1 order of magnitude bigger than that of MoS₂ obtained by ALD, much smaller Tafel slope (47–50 mV dec⁻¹) of MoS₂ than that (88 mV dec⁻¹) of Au indicates MoS₂ has a better HER activity than Au [62]. HER mechanism of ALD-MoS₂ catalysts is the same because the Tafel slopes of ALD-MoS₂ catalysts are in a small range (47–57 mV dec⁻¹), and the main pathway for the HER may be the VH (Volmer-Heyrovsky) [63].

Moreover, a type II heterojunction can be formed by coating MoS₂ on Si [64–66]. In the MoS₂/Si heterostructure, photoexcited electrons in Si will also participate in the HER by transporting to the Si/MoS₂ and MoS₂/H₂O interfaces. Nanocrystal MoS₂ films grew on p-Si by ALD

Figure 8 (a) HER polarization curves of bare Au and MoS₂/Au. Reprinted with permission from Ref. [31], Copyright 2015, American Chemical Society. (b) HER polarization curves of bare CFP and MoS₂/CFP. Reprinted with permission from Ref. [34], Copyright 2016, Royal Society of Chemistry. (c) PEC HER polarization curves of bare p-Si, as-grown and sulfurized MoS₂/p-Si. Reprinted with permission from Ref. [42], Copyright 2017, Royal Society of Chemistry. (d) OER polarization curves of bare Co foam and Co@MoS₂-500 grown by various cycles. Reprinted with permission from Ref. [43], Copyright 2017, Royal Society of Chemistry.

Table 3 Electrocatalytic activity of MoS₂ obtained by ALD

Sample	Tafel slope (mV dec ⁻¹)	J_0 (μA cm ⁻²)	TOF at 0.2 V vs. RHE (H ₂ s ⁻¹)	Ref.
Bare Au	88	0.293	/	[31]
MoS ₂ (2.0 nm)	50	0.024	/	
MoS ₂ (9.4 nm)	47	0.027	1.45	
Bare CFP	/	/	/	[34]
MoS ₂ (20 cycles)	56.6	0.025	0.2–0.5	
MoS ₂ (60 cycles)	56.5	0.039	0.3–0.8	
MoS ₂ (100 cycles)	55.8	0.039	0.4–0.9	
MoS ₂ (150 cycles)	55.6	0.027	0.3–0.7	

using Mo(CO)₆ and H₂S at 200°C. Bare p-Si, as-grown MoS₂/p-Si, and post-annealing MoS₂/p-Si were used for the photoelectrochemical (PEC) H₂ [42]. Their PEC polarization curves are shown in Fig. 8c, where the overpotential of MoS₂/p-Si is much smaller than that of bare p-Si at the same current density, indicating ALD-MoS₂ can obviously improve the PEC activity. ALD-MoS₂ was also used as a catalyst for the O₂ evolution reaction

(OER) [43,67,68]. The OER polarization curves of bare Co, Co@MoS₂-500 and Co@MoS₂-1000 are shown in Fig. 8d, where the overpotential of Co@MoS₂ is much smaller than that of bare Co at the same current density, indicating the ALD-MoS₂ has a better catalytic activity for OER. Moreover, the similar polarization curves of Co@MoS₂-500 and Co@MoS₂-1000 indicate the catalytic activity is insensitive to the thickness of MoS₂.

As described above, as an electrochemical catalyst, ALD-MoS₂ has the excellent catalytic activity both for HER and OER. The catalytic activity is insensitive to the number of cycles till it forms a continuous MoS₂ film. However, the thickness of MoS₂ has influence on the properties of Si/MoS₂ heterostructures such as the optical absorption, charge separation, and recombination, and thus affects the PEC activity. ALD-MoS₂ with the amorphous structure has higher activity than that with the nanocrystal structure owing to the abundant active sites. Moreover, post-annealing can further improve the activity of MoS₂, because annealing can make the grain perpendicular to the substrate and expose more active edges.

Therefore, there are two aspects needing to be paid attention to for improving the catalytic activity of ALD-MoS₂. The one is to make the MoS₂ grain as small as possible and perpendicular to the substrate, thus exposing as many active sites as possible, which can be achieved by controlling the processes of the growth and post-annealing. In order to obtain the MoS₂ grain with a small size, ALD should be carried out by using the metal-organic compound with a high reactivity as the Mo-precursor, and the substrate should avoid the plasma clean to keep the low surface energy. The MoS₂ grain perpendicular to the substrate can be obtained by controlling post-annealing parameters such as the temperature, rates of heating and cooling. The other is to improve the conductivity of MoS₂ through the doping of the conductive metal like Cu and Ag. However, it is a challenge that keeping the small ΔG_{H^+} of MoS₂ edge unchangeable when the doping is introduced.

CONCLUSION AND OUTLOOK

In the ALD process, precursors, substrates, temperature and post-annealing treatments have influences on the quality of the MoS₂ films. To directly and safely obtain high-quality MoS₂ films by ALD, searching for novel precursors and optimizing process parameters are necessary. Metal-organic compound and metal-halide are used as Mo-precursors to deposit the MoS₂ films. Metal-organic compound has a high reactivity while the obtained MoS₂ films have a low crystallinity and GPC. Crystal structures, surface functional groups and micro-structures of the substrates are also very important to ALD of MoS₂. Hexagonal crystal substrates, acid pickling or plasma treating to increase the hydroxyl density of the substrate surface, annealing the substrate at ~200°C to vanish the hydrogen-bonded hydroxyl groups may be useful for obtaining high crystalline MoS₂ films by ALD.

Although the growth temperature is elevated to enlarge the size of the MoS₂ grain obtained by ALD, the grain is still much smaller than that obtained by CVD. Therefore, in order to improve the crystalline quality, the post-annealing is necessary.

Although the crystallinity of MoS₂ obtained by ALD is lower than that obtained by CVD, the ALD-MoS₂ film has shown excellent electrochemical properties as a catalyst in HER, OER, and PEC, which benefits from the abundant activity sites. The remaining challenge is how to improve the conductivity of ALD-MoS₂ and keep the small ΔG_{H^+} unchangeable at the same time.

Adhesion and friction between contact surfaces seriously hinder the reliability and performance of the micro-electro-mechanical system (MEMS). In order to solve the problems, lubricant and protective films are usually coated on the surface of MEMS. Comparing with traditional technologies such as physical or chemical vapor deposition (PVD or CVD), ALD can easily deal with the challenge that how to conformally coat the film on the three-dimensional structure of MEMS. Therefore, as an excellent lubricating material, the MoS₂ film obtained by ALD may provide the low friction surface required in MEMS.

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原子层沉积二硫化钼的研究进展

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摘要 作为一种特殊的化学气相沉积技术, 原子层沉积在薄膜制造领域得到广泛的应用. 得益于自限制化学反应, 原子层沉积所制备的薄膜具有优异的均匀性且精确可控. 基于原子层沉积技术, 在复杂、大面积基底上制备的薄膜厚度可以控制在原子尺度精度(0.1 nm). 因此, 它已经被用来制备二维MoS₂材料. 本综述首先介绍了原子层沉积MoS₂薄膜的相关研究进展, 然后就前驱体、衬底、温度和退火等工艺参数对薄膜质量的影响进行了分析, 最后对原子层沉积制备的MoS₂在电化学催化领域的应用进行了评论. 该综述不仅回顾了原子层沉积MoS₂的研究进展, 而且指出了尚存的挑战和突破的希望.